Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/623,576	CHEN ET AL.	
Examiner	Art Unit	
Joseph Haley	2627	

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	SEAR	CHED	
Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
	interference arch	11/28/2006	JRH

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
see updated EAST search notes	11/28/2006	JRH